Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10540270	NAKANISHI ET AL.
Examiner	Art Unit

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SEARCHED						
Class	Subclass	Date	Examiner			
430	109.4, 124.1	11/29/2007	RLB			
528	272	11/29/2007	RLB			

Burney, Rachel L

SEARCH NOTE	S	
Search Notes	Date	Examiner
Inventorship Search	11/29/2007	RLB
Text search in EAST (see search history print out)	11/29/2007	RLB
Consulted with SPE Mark Huff	12/03/2007	RLB

INTERFERENCE SEARCH						
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